

<b>Notice of References Cited</b>	Application/Control No. 10/673,336	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner Chuc D. Tran	Art Unit 2821	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,433,756	08-2002	Sievenpiper et al.	343/909
	B	US-2005/0017919	01-2005	Sievenpiper et al.	343/909
	C	US-6,593,894	07-2003	Biswas et al.	343/793
	D	US-6,262,495	07-2001	Yablonovitch et al.	307/101
	E	US-5,541,614	07-1996	Lam ´et al.	343/792.5
	F	US-2005/0068233	03-2005	Tanaka et al.	343/700.0MS
	G	US-5,923,225	07-1999	De Los Santos, Hector J.	333/12
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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